

# 1.1 eV GaInAs Cell Development for Dual-use Solar and 1075 nm Laser Power Converters

D. T. T. Meeker<sup>1,2</sup>, R. M. France<sup>1</sup>, J. F. Geisz<sup>1</sup>, K. T. VanSant<sup>1</sup>, S. Collins<sup>1</sup>, D. J. Friedman<sup>1</sup>

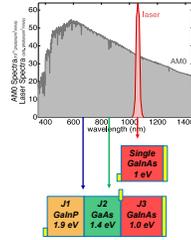
<sup>1</sup>National Renewable Energy Laboratory, Golden, CO 80401, United States

<sup>2</sup>Colorado School of Mines

## Introduction

- Dual-use PV concept
  - PV: Broad-spectrum energy conversion
  - LPC: High-efficiency single-wavelength conversion
- Benefits
  - Reduce solar panel area and required storage capacity of assets
  - Space applications: satellites, bases, rovers, etc.
- Challenges
  - Metamorphic cell growth, high temps, resistance losses

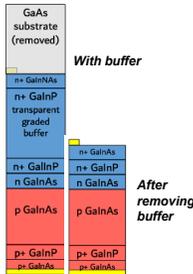
Dual-use 1J and 3J spectrum



## Cell Concepts

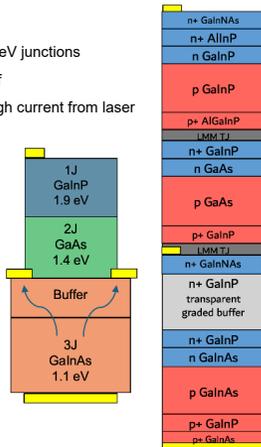
### Single Junction Structure

- Two cell concepts
  - MOVPE growth
  - Inverted metamorphic
  - 1.1eV junction to target 1075nm laser
- Single junction
  - Buffer layers removed
  - Ga<sub>0.2</sub>In<sub>0.8</sub>As
  - Higher LPC efficiency, lower broadband efficiency



### Triple Junction Structure

- Triple junction
  - Addition of 1.4eV and 1.9eV junctions
  - Buffer layer not etched off
  - Third contact to collect high current from laser
- Addition of third contact puts more emphasis on lateral current pathways (shown by blue arrows) which is highly dependent on sheet resistance



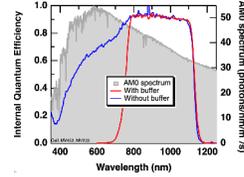
## Single Junction Analysis

### Solar Performance

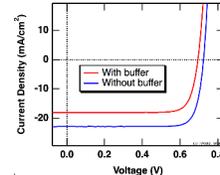
- QE shows broadband absorption of solar spectrum
- 1.1eV ideal for 1075nm wavelength (1.15eV)
- Characterized for AM0 spectrum
- Without contact layer & buffer, GaInP window layer is still partially absorbing
- JV curve shows improvement to J<sub>sc</sub> after removing buffer layer
  - Almost no effect to V<sub>oc</sub>

	V <sub>oc</sub> (V)	J <sub>sc</sub> (mA/cm <sup>2</sup> )	FF (%)	EF (%)
Buffer	0.68	19.2	80.2	7.66
No Buffer	0.72	22.3	81.9	9.6

### Quantum Efficiency

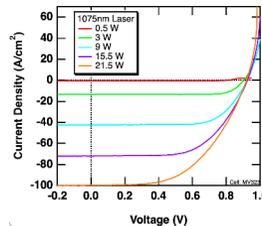


### JV curves



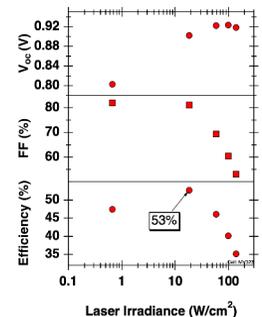
## Laser Performance

### JV Curves



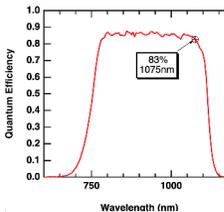
- Goal: design cell for laser irradiance of 1-10 suns
- Cell area = .01 cm<sup>2</sup>
- Used real laser
- As laser irradiance increases...
  - J<sub>sc</sub> & V<sub>oc</sub> increase
  - Fill factor decreases
  - Resistance losses dominate
- ARC increased QE to 83% at 1075nm

### Laser analysis



- Adding an ARC increased LPC efficiency to 53% at 18 W/cm<sup>2</sup>
- $\eta = \frac{P_{cell}}{e_{tot}} = \frac{V_{mpp} J_{mpp}}{J_{sc} / qE(\lambda) \cdot hc / qa}$

### Quantum Efficiency

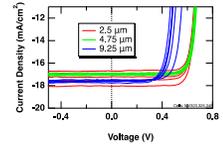


## Triple Junction Analysis

### Buffer Thickness Experiment

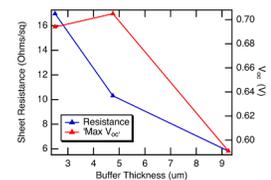
- GaInP graded buffer changes lattice constant to grow GaInAs on GaAs substrate
- In 1J, optimized buffer reduces threading dislocation density
  - Decreases non-radiative recombination
  - Increases V<sub>oc</sub>
- In 3J, buffer serves also as a lateral transport to intermediate contact
  - Sheet resistance is key

### JV curves



Thickness (μm)	V <sub>oc</sub> (V)	J <sub>sc</sub> (mA/cm <sup>2</sup> )	FF (%)
2.5	0.689	17.2	81.3
4.75	0.694	16.9	81.9
9.25	0.534	17.6	74.9

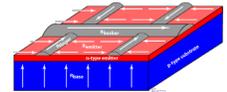
### Sheet resistance vs. buffer thickness



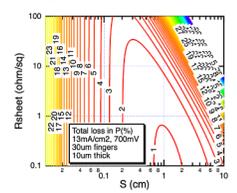
- Results show increasing buffer thickness decreases sheet resistance
- If buffer is too thick, cell quality decreases
- Optimal thickness around 5μm

## Resistance Modeling

- Goal: Determine power loss given cell size
- Resistance values of interest
  - Sheet, contact, grid finger, base
- More grid fingers → lower resistance loss → more shadowing
- Optimal buffer thickness has sheet resistance of ~10 ohms
- Fabrication requires fingers only on cell perimeter



### Power loss (%) for R<sub>sheet</sub> and grid finger spacing (S)



## Summary

- 53% laser conversion efficiency achieved on lattice mismatched GaAs cell at 1075nm
- Buffer thickness optimized for cell quality in both 1J and 3J
  - Reduce threading dislocation in PN junction for 1J and 3J
  - Reduce sheet resistance for 3J
- Optimal grid finger spacing for cell is 0.2-1cm